



## BT131-6/8

TRIAC

TO-92

### MAIN FEATURES

Symbol	value	unit
$I_{T(RMS)}$	1	A
$V_{DRM}/V_{RRM}$	BT131-6	400 V
	BT131-8	600 V
$I_{TSM}$	8	A

1. ANODE

2. GATE

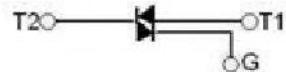
3. ANODE



### DESCRIPTION

Logic level sensitive gate triac intended to be interfaced directly to microcontrollers, logic integrated circuits and other low power gate trigger circuits.

### Equivalent Circuit



### FEATURES

- Blocking voltage to 400 V
- RMS on-state current to 0.6 A
- General purpose bidirectional switching

### APPLICATIONS

- General purpose bidirectional switching
- Phase control applications
- Solid state relays

## Limiting values

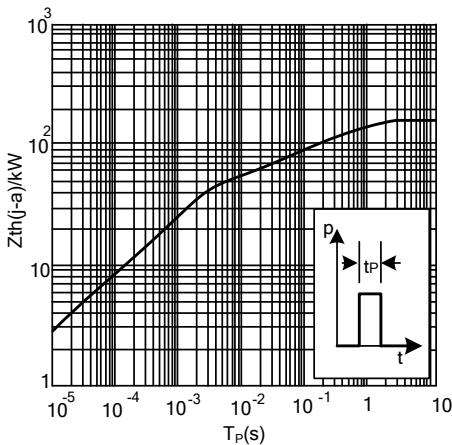
Symbol	Parameter	Conditions	Value	Unit
$V_{DRM} / V_{RRM}$	repetitive peak off-state voltage	BT131-6	$T_j = 25 \text{ to } 125^\circ\text{C}$	400
		BT131-8	$T_j = 25 \text{ to } 125^\circ\text{C}$	600
$I_{GM}$	gate current(peak value)	$t = 2\mu\text{s} \text{ max}$	1	A
$V_{GM}$	gate voltage(peak value)	$t = 2\mu\text{s} \text{ max}$	5	V
$P_{GM}$	gate power(peak value)	$t = 2\mu\text{s} \text{ max}$	5	W
$T_j$	Junction Temperature	-	-40 ~ 125	$^\circ\text{C}$
$T_{stg}$	Storage Temperature	-	-40 ~ 150	$^\circ\text{C}$

## ELECTRICAL CHARACTERISTICS ( $T_a=25^\circ\text{C}$ unless otherwise specified)

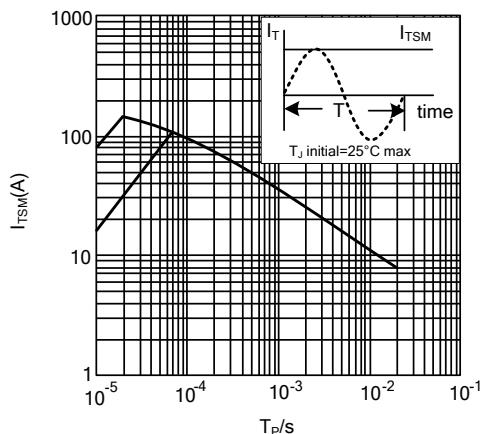
Parameter	Symbol	Test conditions		Min	Max	Unit
Rated repetitive peak off-state/reverse voltage	$V_{DRM}, V_{RRM}$	$I_D=10\mu\text{A}$	BT131-6	400		V
			BT131-8	600		
Rated repetitive peak off-state current	$I_{DRM}$	$V_D=V_{DRM}$			10	$\mu\text{A}$
On-state voltage	$V_{TM}$	$I_T=1\text{A}, I_G=50\text{mA}$			1.9	V
Gate trigger current	I	$I_{GT}$	$T_2(+), G(+)$		5	$\text{mA}$
	II		$T_2(+), G(-)$		5	$\text{mA}$
	III		$T_2(-), G(-)$		5	$\text{mA}$
	IV		$T_2(-), G(+)$		-	$\text{mA}$
Gate trigger voltage	I	$V_{GT}$	$T_2(+), G(+)$		1.5	V
	II		$T_2(+), G(-)$		1.5	V
	III		$T_2(-), G(-)$		1.5	V
	IV		$T_2(-), G(+)$		-	V
Holding current	$I_H$	$I_T=600\text{mA}, I_G=20\text{mA}$			10	$\text{mA}$

## ■ TYPICAL CHARACTERISTICS

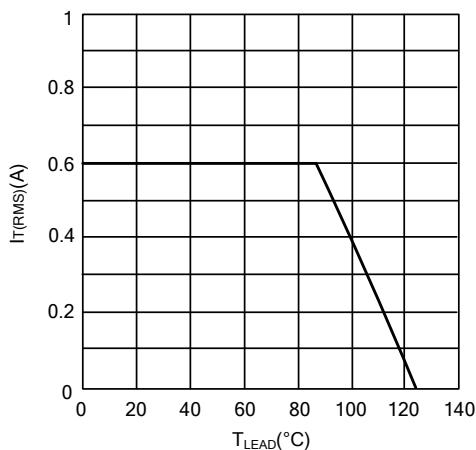
Transient Thermal Impedance From Junction to Ambient as a Function of Pulse Duration.



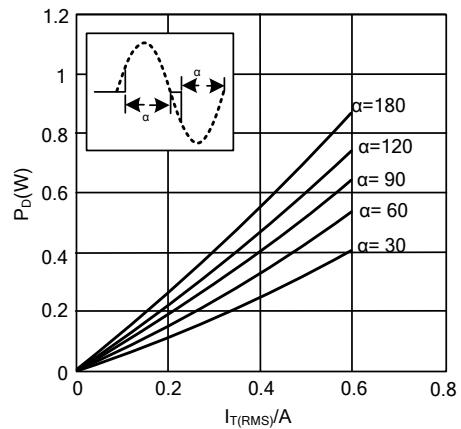
Maximum Permissible Non-Repetitive Peak on-State Current as a Function of Pulse Width for Sinusoidal Currents; Typical Values.  $t_{PL} \parallel 20\text{ms}$ .



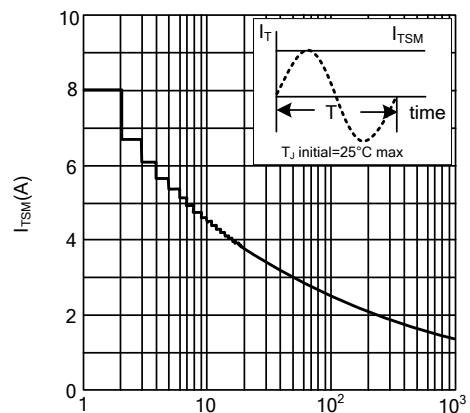
Maximum Permissible RMS Current as a Function of Lead Temperature; Typical Values.



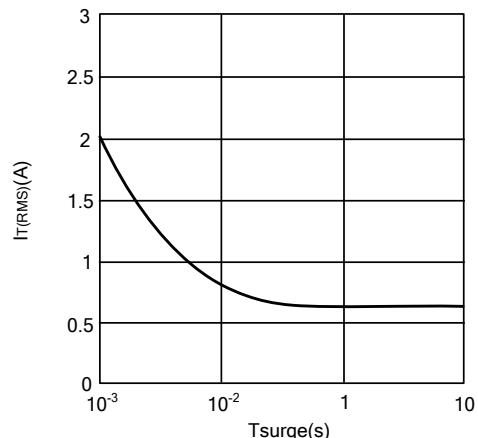
Maximum On-State Dissipation as a Function of RMS On-State Current; Typical Values.  $\alpha$ =Conduction Angle.



Maximum Permissible Non-Repetitive Peak On-State Current as a Function of Number of Cycles for Sinusoidal Currents; Typical Values.  $n$ =Number of Cycles at  $f=50\text{Hz}$ .

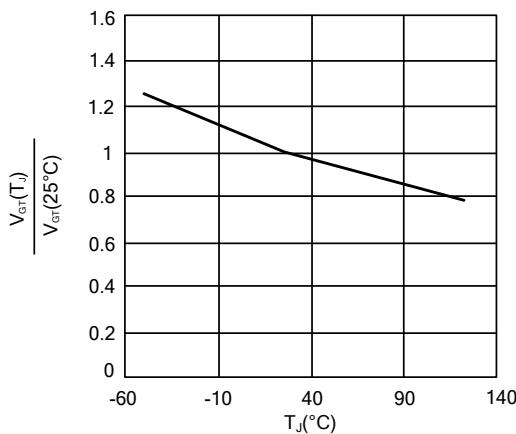


Maximum Permissible Repetitive RMS On-State Current as a Function of Surge Duration for Sinusoidal Currents; Typical Values.  $f=50\text{Hz}$ ;  $T_{LEAD} \parallel 50^\circ C$

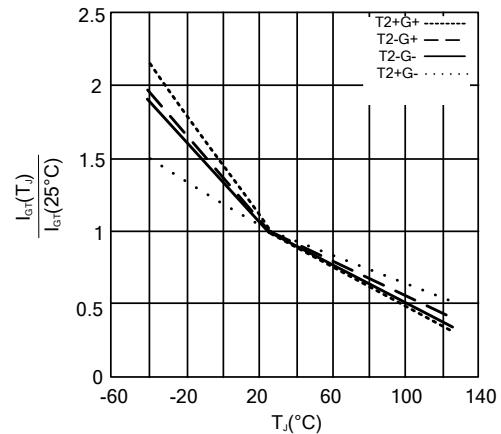


## ■ TYPICAL CHARACTERISTICS(Cont.)

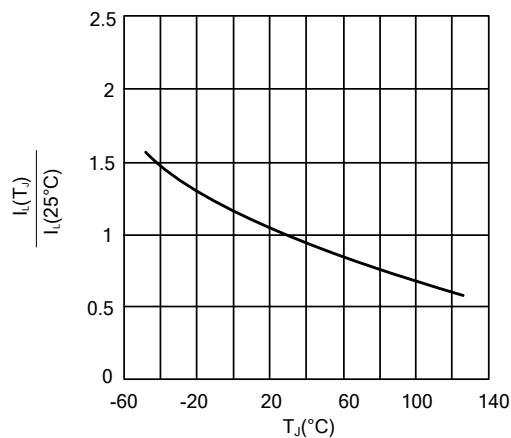
Normalized Gate Trigger Voltage as a Function of Junction Temperature; Typical Values.



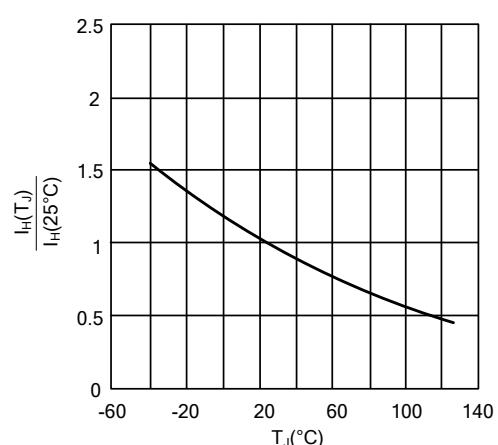
Normalized Gate Trigger Current as a Function of Junction Temperature; Typical Values.



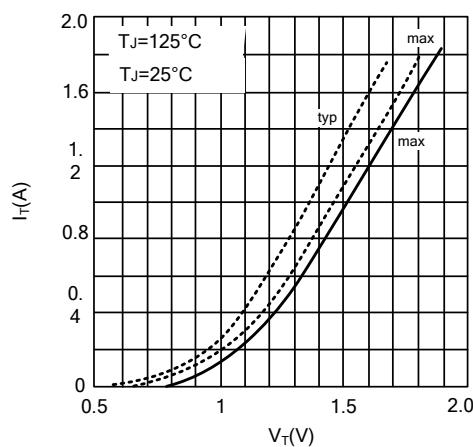
Normalized Latching Current as a Function of Junction Temperature; Typical Values.



Normalized Holding Current as a Function of Junction Temperature; Typical Values.



On-State Current as a Function of On-State Voltage; Typical and Maximum Values.



Critical Rate of Rise of Off-State Voltage as a Function of Junction Temperature; Typical Values.

